

| | | | | |
|-----------------------------------|--|-------------------------|---|-------------|
| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination | |
| | | 10/002,238 | WANG, FU-HWA | |
| | | Examiner | Art Unit | Page 1 of 1 |
| | | Satish S. Rampuria | 2124 | |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------------|----------------|
| | A | US-6,625,807 B1 | 09-2003 | Chen, Ding-Kai | 717/154 |
| | B | US-6,549,959 B1 | 04-2003 | Yates et al. | 710/22 |
| | C | US-6,397,379 B1 | 05-2002 | Yates et al. | 717/140 |
| | D | US-6,374,403 B1 | 04-2002 | Darte et al. | 717/161 |
| | E | US-6,289,505 B1 | 09-2001 | Goebel, Kurt Joachim | 717/153 |
| | F | US-6,151,618 A | 11-2000 | Wahbe et al. | 718/1 |
| | G | US-6,609,248 B1 | 08-2003 | Srivastava et al. | 717/147 |
| | H | US-6,353,925 B1 | 03-2002 | Stata et al. | 717/112 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | Cifuentes, Partial automation of an integrated reverse engineering environment of binary code, Reverse Engineering, 1996., Proceedings of the Third Working Conference on , 8-10 Nov. 1996, Pages:50 - 56 |
| | V | Ung et al., Dynamic re-engineering of binary code with run-time feedbacks, Reverse Engineering, 2000. Proceedings. Seventh Working Conference on , 23-25 Nov. 2000, Pages:2 - 10 |
| | W | Ebciooglu et al., Dynamic binary translation and optimization, Computers, IEEE Transactions on , Volume: 50 , Issue: 6 , June 2001, Pages:529 - 548 |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.